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PTO-1390 (Rev. 07-2005) Approved for use through 3/31/2007. OMB 0651-0021

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## TRANSMITTAL LETTER TO THE UNITED STATES DESIGNATED/ELECTED OFFICE (DO/EO/US) CONCERNING A SUBMISSION UNDER 35 U.S.C. 371

ATTORNEY'S DOCKET NUMBER
TPO-5168 filed Jan. 23, 2006
U.S. APPLICATION NO. (If known, See CFR 1.5)

INTERNATIONAL APPLICATION NO. March 22, 2004 PRIORITY DATE LAIMED

TITLE OF INVENTION PROBE. REPLACEMENT METHOD FOR SCANNING PROBE MICROSCOPE

APPLICANT(S) FOR DO/EO/USKEN MURAYAMA, YUKIO KENBUU, YUUICHI KUNITOMO, Takenori HTROKT,
Yoshiyuki NAGANO, Takafumi: MORIMOTO, Tooru KURENUMA, Hiroaki YANAGIMOTO, Hiroshi KURODA,
Applicant herewith submits to the United States Designated/Elected Office (DO/EO/US) the following items and other information:

1. XX This is a FIRST submission of items concerning a submission under 35 U.S.C. 371.

2. This is a SECOND or SUBSEQUENT submission of items concerning a submission under 35 U.S.C. 371.

3.	LJ	This is an express request to begin national examination procedures (35 U.S.C. 371(f)). The submission must include items (5), (6), (9) and (21) indicated below.			
4.	x	The US has been elected (Article 31).			
5.	XX	A copy of the International Application as filed (35 U.S.C. 371(c)(2))			
		a. is attached hereto (required only if not communicated by the International Bureau).			
		b. X has been communicated by the International Bureau.			
		c. is not required, as the application was filed in the United States Receiving Office (RO/US).			
6.	XX	An English language translation of the International Application as filed (35 U.S.C. 371(c)(2)).			
		a. XX is attached hereto.			
		b. has been previously submitted under 35 U.S.C. 154(d)(4).			
7.		Amendments to the claims of the International Application under PCT Article 19 (35 U.S.C. 371(c)(3))			
		a. are attached hereto (required only if not communicated by the International Bureau).			
		b. have been communicated by the International Bureau.			
		c. have not been made; however, the time limit for making such amendments has NOT expired.			
		d. have not been made and will not be made.			
8.		An English language translation of the amendments to the claims under PCT Article 19 (35 U.S.C. 371(c)(3)).			
9.		An oath or declaration of the inventor(s) (35 U.S.C. 371(c)(4)).			
10.		An English language translation of the annexes of the International Preliminary Examination Report under PCT Article 36 (35 U.S.C. 371(c)(5)).			
	ltem	s 11 to 20 below concern document(s) or information included:			
11.	X	An Information Disclosure Statement under 37 CFR 1.97 and 1.98.			
12.		An assignment document for recording. A separate cover sheet in compliance with 37 CFR 3.28 and 3.31 is included.			
13.	XX	A preliminary amendment.			
14.		An Application Data Sheet under 37 CFR 1.76.			
15.		A substitute specification.			
16.		A power of attorney and/or change of address letter.			
17.		A computer-readable form of the sequence listing in accordance with PCT Rule 13ter.2 and 37 CFR 1.821- 1.825.			
18.		A second copy of the published International Application under 35 U.S.C. 154(d)(4).			
19.	$\sqcup$	A second copy of the English language translation of the international application under 35 U.S.C. 154(d)(4).			

This collection of information is required by 37 CFR 1.414 and 1.491-1.492. The information is required to obtain or retain a benefit by the public, which is to file (and by the USPTO to process) an application. Confidentiality is governed by 35 U.S.C. 122 and 37 CFR 1.11 and 1.14. This collection is estimated to take 15 minutes to complete, including gathering information, preparing, and submitting the completed form to the USPTO. Time will vary depending upon the individual case. Any comments on the amount of time you require to complete this form and/or suggestions for reducing this burden, should be sent to the Chief Information Officer, U.S. Patent and Trademark Office, U.S.

**\*6339** 

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U.S. APPLICA	TION NO (if known)	ATTORNEY'S DOCKET NUMBER TPO-5168						
Other items or information: Continuation of List of Inventors: Shigeru MIWA and Takashi FURUTANI. International Publication NO.; WO2005/019592Al-cover sheet, PCT Request Form, International Preliminary Examination Report, International Search Report w/cited Refs., Figs. 1-19, Credit Card Payment Form, List of Inventors Names and Addresses								
The foll	owing fees have b	een submitted			CALCULATIONS	PTO USE ONLY		
21. X Basic national fee (37 CFR 1.492(a))					\$ 300.00			
22. X Exam	nination fee (37 CF	FR 1.492(c))						
by IPEA/	nion prepared by IS US indicates all cl ns	\$ 200.00						
If the written opin IPEA/US Search fee (37 C International Sea previously	rch fee (37 CFR 1. nion of the ISA/US indicates all claim FR 1.445(a)(2)) had onal Searching Au arch Report prepart y communicated to	400.00 \$						
	TOTAL OF 21, 22	2 and 22 =			900.00			
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			TOTAL OF ABOVE	CALCULATIONS =	\$ 900.00			
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	00 Diagonal Road		Shrinath Malur			
	ite 370		NAME			
	exandria, Vai 22314		34,663			
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			12			



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